

<b>Notice of References Cited</b>	Application/Control No. 10/709,853	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0133374	07-2003	Murata et al.	369/44.35
*	B	US-5,914,922	06-1999	Supino et al.	369/44.28
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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